SPECIFICATION

SPEC. No. Mega-a

D A T E: 2013 Sep.

То

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS

CKG Series / Commercial and Automotive Grade

MEGACAP Type

Please return this specification to TDK representatives.

If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group TDK-EPC Corporation

Engineering

Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK-EPC Corporation Japan,

TDK (Suzhou) Co., Ltd and TDK Components U.S.A. Inc.

EXPLANATORY NOTE:

This specification warrants the quality of the ceramic chip capacitors. The chips should be evaluated or confirmed a state of mounted on your product.

If the use of the chips goes beyond the bounds of the specification, we can not afford to guarantee.

2. CODE CONSTRUCTION

(Example)

Catalog Number :	CKG32K	<u>X7R</u>	<u>1E</u>	<u>106</u>	<u>K</u>	<u>335</u>	<u>A</u>	<u>H</u>
(Web)	CKG45N	<u>X7R</u>	<u>1C</u>	<u>226</u>	M	<u>500</u>	<u>J</u>	<u>H</u>
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
Item Description :	CKG32K	<u>X7R</u>	<u>1E</u>	<u>106</u>	<u>K</u>	<u>T</u>	XXXX	
	CKG45N	<u>X7R</u>	<u>1C</u>	<u>226</u>	<u>M</u>	<u>T</u>	XXXX	
	(1)	(2)	(3)	(4)	(5)	(9)	(10)	

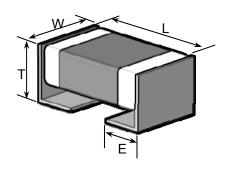
(1) Type

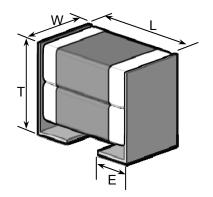
Single type

CKG**K: 1 chip capacitor.

Stacked type

CKG**N: 2 chip capacitors.





Please refer to product list for the dimension of each product.

- (2) Temperature Characteristics (Details are shown in table 1 No.6 at page 3)
- (3) Rated Voltage

Symbol	Rated Voltage
2 J	DC 630 V
2 W	DC 450 V
2 E	DC 250 V
2 A	DC 100 V
1 H	DC 50 V
1 E	DC 25 V
1 C	DC 16 V



(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

Example 106 \rightarrow 10,000,000pF 226 \rightarrow 22,000,000pF

(5) Capacitance tolerance

Symbol	Tolerance
K*1	± 10 %
M	± 20 %(standard)

^{*1} As for CKG**K type with 10uF under, applied to K and M tolerance.

- (6) Thickness code (Only Catalog Number)
- (7) Package code (Only Catalog Number)
- (8) Special code (Only Catalog Number)
- (9) Packaging (Only Item Description)

Symbol	Packaging
Т	Taping

(10) Internal code (Only Item Description)

3. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
X5R	-55°C	85°C	25°C
X7R, X7S, X7T	-55°C	125°C	25°C

4. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH

6 months Max.

5. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.



6. PERFORMANCE

table 1

No.	Item	Performance	Test or inspection method		
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3×)		
2	Insulation Resistance	500MΩ·μF min. (As for the capacitors of rated voltage 16V DC, 100MΩ·μF min.,) whichever smaller.	Apply rated voltage for 60s. As for the rated voltage 630V DC, apply 500V DC.		
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.	Rated voltage Apply voltage 100V and under 2.5 × rated voltage Over 100V 1.5 × rated voltage Above DC voltage shall be applied for 1 to 5s. Charge / discharge current shall not exceed 50mA.		
4	Capacitance	Within the specified tolerance.	Rated Measuring Measuring Capacitance frequency voltage 10uF and under 1kHz±10% 1.0±0.2Vrms. Over 10uF 120Hz±20% 0.5±0.2Vrms.		
5	Dissipation Factor	T.C. D.F. X5R 0.03 max. X7R 0.05 max. X7S 0.075 max. X7T 0.10 max.	See No.4 in this table for measuring condition. For information which product has which Dissipation Factor, please contact with our sales representative.		
6	Temperature Characteristics of Capacitance	Capacitance Change (%) No voltage applied X5R: ±15 X7R: ±15 X7S: ±22 X7T: +22 -33	Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step. ΔC be calculated ref. STEP3 reading Step Temperature(°C) 1 Reference temp. ± 2 2 Min. operating temp. ± 2 3 Reference temp. ± 2 4 Max. operating temp. ± 2		



(continued)

(00)	ntinued)	1		
No.	Item	Performance	Test or inspection method	
7	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1 and apply a pushing force of 5N with 10±1s. Pushing force Capacitor P.C.Board	
8	Bending	No mechanical damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 2 and bend it for 1mm. 50 F R230 (Unit : mm)	
9	Solderability	Both end faces and the contact areas shall be covered with a smooth and bright solder coating with no more than a small amount of scattered imperfections such as pinholes or un-wetted or de-wetted areas. These imperfections shall not be concentrated in one area.	Reflow solder the capacitors on a P.C. Board shown in Appendix 1. Solder: H63A (JIS Z 3282) Flux: Isopropyl alcohol (JIS K 8839) Rosin(JIS K 5902) 25% solid solution.	

(continued)

No.	Ite	em	Performance		Test or inspection method		
10	Temperature Cycle	External appearance	No mechanical damage.		Reflow solder the capacitors on a P.C.Board shown in Appendix 1 before		
	o yo.o	Capacitance			testing	• • •	1 20.010
		Capacitarios	Characteristics	Change from the			
				value before test		e the capacitors in the c	
			X5R X7R X7S X7T	± 7.5 %	step1 through step 4 and repeat 100 consecutively.		at 100 time
					Leave	the capacitors in ambie	nt
		D.F.	Meet the initial s	spec.	condit	ion for 24±2h before me	asurement.
					Step	Temperature(°C)	Time (min.)
		Insulation Resistance	Meet the initial s	spec.	1	Min. operating temp. ± 3	30 ± 3
		Voltage	No insulation br	eakdown or	2	Reference temp. ± 2	2 - 5
		proof	other damage.		3	Max. operating temp. ± 2	30 ± 2
					4	Reference temp. ± 2	2 - 5
11	Moisture	External	No mechanical damage.		Reflow solder the capacitors on a		
	Resistance	appearance			P.C.Board shown in Appendix 1 before		
		Capacitance		Change from the	testing. Apply the rated voltage at temperate		
			Characteristics	value before test			perature
			X5R			2°C and 90 to 95%RH for 500	
			X7R X7S X7T	± 12.5 %	+24,0h. Charge/discharge current shall not		
				<u> </u>			iall not
		D.F.	Characteristics X5R/X7R/X7S/X7T:		exceed 50mA.		
			200% of initial spec. max.			the capacitors in ambie	
		Insulation	25MΩ·μF min.		condition for 24±2h before measureme		asurement.
		Resistance	(As for the capa				
			voltage 16V DC, 5MΩ·μF min.,).		Voltage conditioning Voltage treat the capacitors under		
					hour.	temperature and voltag	J e IOI I
						the capacitors in ambie	nt
						ion for 24±2h before	111
						irement.	
		1			Use this measurement for initial value.		

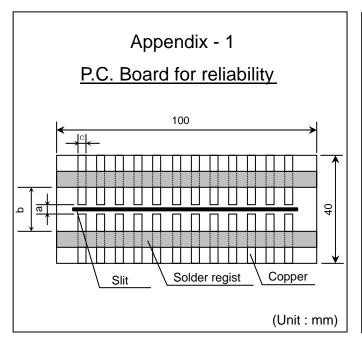


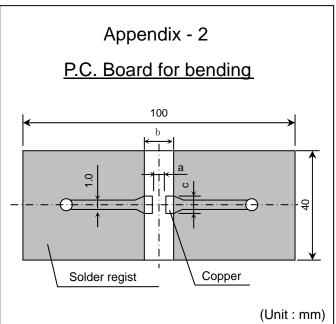
(continued)

No.	lt lt	tem	Perfo	rmance	Test or inspection method
12	Life	External appearance	No mechanical of	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1 before
		Capacitance	Characteristics X5R X7R X7S X7T	Change from the value before test ± 15 %	testing. Below the voltage shall be applied at Maximum operating temperature ±2°C for 1,000 +48, 0h.
		D.F.	Characteristics X5R/X7R/X7S/ 200% c	X7T : of initial spec. max.	Applied voltage Rated voltage x2 Rated voltage x1.5
		Insulation Resistance	50MΩ·μF min. (As for the capa voltage 16V DC	citors of rated , 10MΩ·μF min.,)	Rated voltage x1.2 Rated voltage x1 For information which product has which applied voltage, please contact with our sales representative. Charge/discharge current shall not exceed 50mA. Leave the capacitors in ambient condition for 24±2h before measurement.
					Voltage conditioning Voltage treat the capacitors under testing temperature and voltage for 1 hour. Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.

^{*}As for the initial measurement of capacitors on number 6 and 10, leave capacitors at $150-10,0^{\circ}$ C for 1 hour and measure the value after leaving capacitors for $24\pm2h$ in ambient condition.







(Unit: mm)

Туре	Dimensions			
TDK(EIA style)	а	b	С	
CKG32K	2.2	5.0	2.9	
CKG45K	3.5	6.1	2.9	
CKG57K	4.1	7.6	4.7	
CKG45N	3.5	6.1	2.9	
CKG57N	4.1	7.6	4.7	

1. Material : Glass Epoxy(As per JIS C6484 GE4)

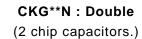
2. Thickness: 1.6mm Copper(Thickness: 0.035mm)

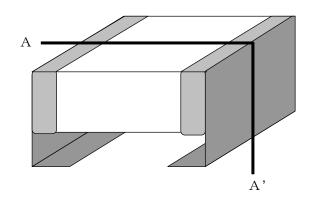
Solder resist

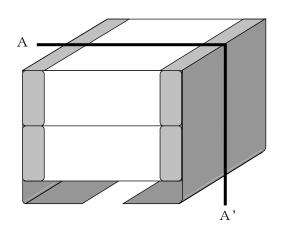


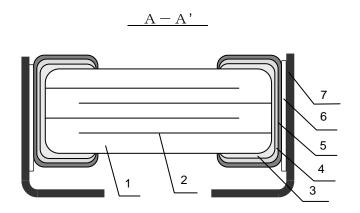
7. INSIDE STRUCTURE AND MATERIAL

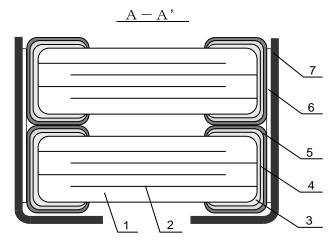
CKG**K : Single (1 chip capacitor.)











No.	NAME	MATERIAL		
1	Dielectric	BaTiO₃		
2	Electrode	Nickel (Ni)		
3		Copper (Cu)		
4	Termination	Nickel (Ni)		
5		Tin (Sn)		
6	Metal cap joint	High temp solder		
7	Metal cap	42 Alloy		

8. RECOMMENDATION

It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux.

And please make sure to dry detergent up completely before.

9. SOLDERING CONDITION

Reflow soldering only.

"Metal cap joint" is high temperature solder, but it may be melted under high temperature (more than 250°C).

Please keep a soldering temperature of 250°C or less and refer to "CAUTION" on page 16-18 in detail.



10. Caution

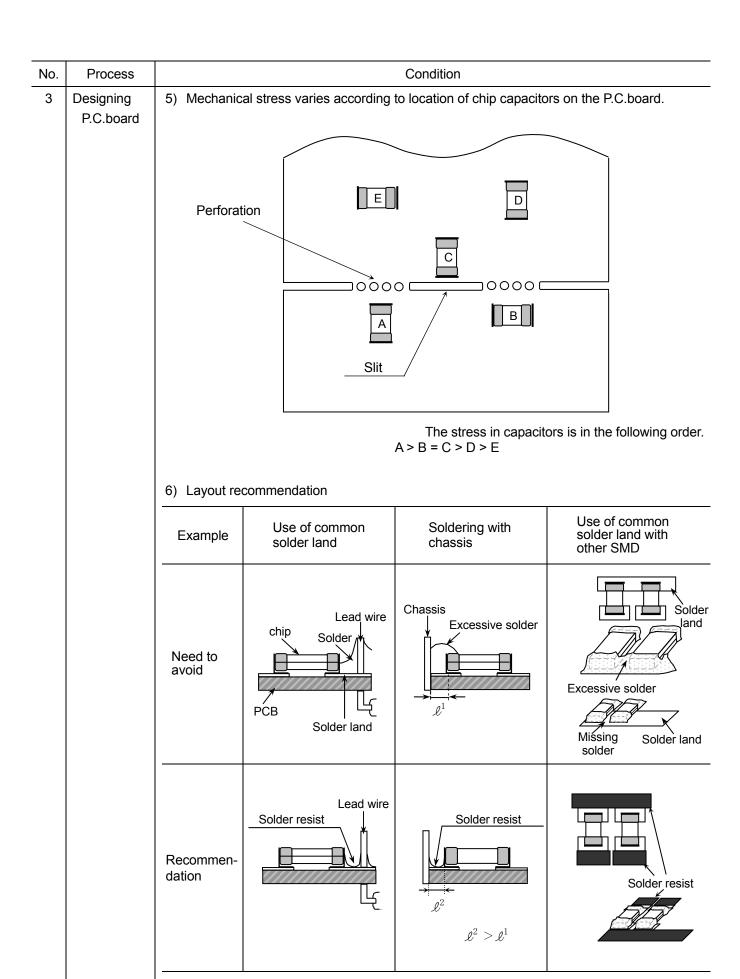
10.	Caution						
No.	Process	Condition					
1	Operating Condition (Storage,	 1-1. Storage 1) The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt. 					
	Transportation)	 The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur. 					
		3) Avoid storing in sun light and falling of dew.					
		4) Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.					
		5) Capacitors should be tested for the solderability when they are stored for long time.					
		1-2. Handling in transportation					
		In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 Handling in transportation)					
2	Circuit design A Caution	 2-1. Operating temperature					
		2) Surface temperature including self heating should be below maximum operating					
		temperature. (Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C)					
		 The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration. Operating voltage Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. 					
		AC or pulse with overshooting, V_{P-P} must be below the rated voltage. (1) and (2)					
		When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.					
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage					
		Positional Measurement (Rated voltage) 0 V _{0-P} 0					
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)					
		Positional Measurement (Rated voltage)					



No.	Process			Condition			
2	Circuit design ⚠ Caution	 Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced. The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound. 					
3	Designing P.C.board	 The amount of solder at the terminations has a direct effect on the reliability of the capacitors. 1) The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations. 2) Avoid using common solder land for multiple terminations and provide individual solder land for each terminations. 3) Size and recommended land dimensions. 				citors, nine the ne	
		(mm)					
		Type Symbol	CKG32K	CKG45K CKG45N	CKG57K CKG57N		
		A	2.0 – 2.2	3.3 – 3.7	3.9 – 4.3		
		B	1.1 - 1.3	1.2 - 1.5	1.5 – 2.0		
C 2.3 – 2.5 2.7 – 3.2 4.5 – 5.0					45 50		



No.	Process		Condition					
3	Designing P.C.board	4) Recommended	4) Recommended chip capacitors layout is as following.					
			Disadvantage against bending stress	Advantage against bending stress				
		Mounting face	Perforation or slit	Perforation or slit				
			Break P.C.board with mounted side up.	Break P.C.board with mounted side down.				
		Chip arrangement (Direction)	Mount perpendicularly to perforation or slit Perforation or slit	Mount in parallel with perforation or slit Perforation or slit				
		Distance from slit	Closer to slit is higher stress $ \begin{pmatrix} \ell_1 \\ \ell_2 \end{pmatrix} $	Away from slit is less stress ℓ_2 $(\ell_1 < \ell_2)$				



No.	Process		Condition				
4	Mounting	 4-1. Stress from mounting head If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitors to result in cracking. Please take following precautions. 1) Adjust the bottom dead center of the mounting head to reach on the P.C.board surface and not press it. 					
		2) Adjust the mour	nting head pressure to be 1 to 3N	of static weight.			
		support from the	 To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. See following examples. 				
			Not recommended	Recommended			
		Single sided mounting	Crack	Support pin			
		Double-sides mounting	Solder Crack	Support pin			
		to cause crack. P	ng jaw is worn out, it may give me Please control the close up dimens preventive maintenance and repla	echanical impact on the capacitors ion of the centering jaw and			

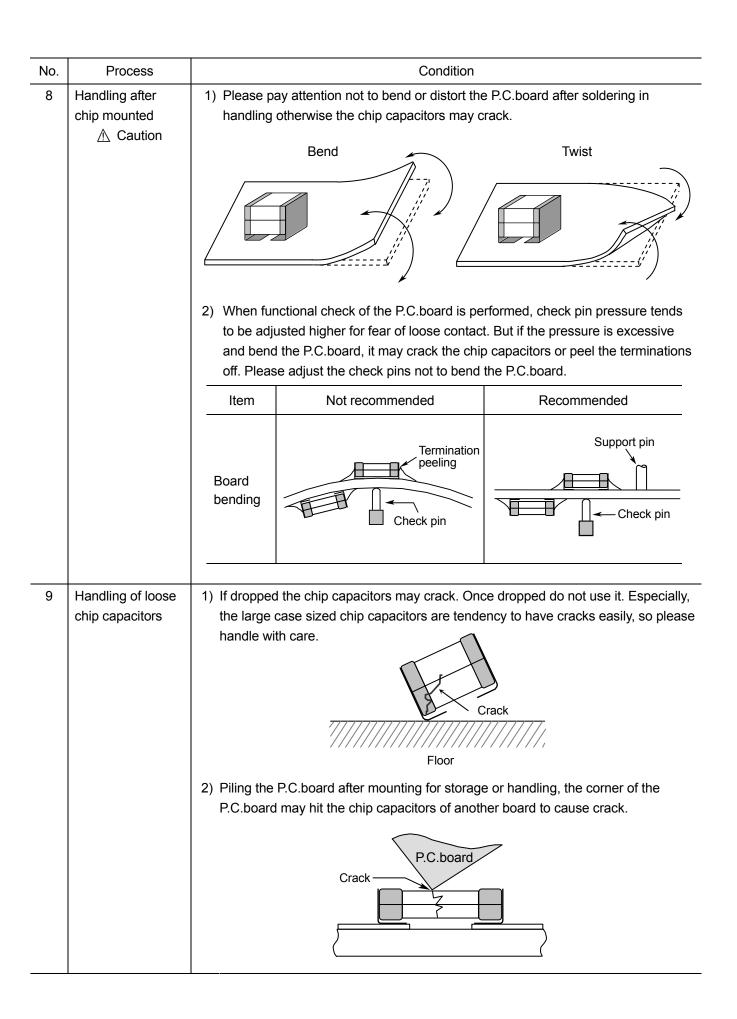
No.	Process		Condition	on		
5	Soldering 5-1. Flux selection Although highly-activated flux gives better solderability, substances activity may also degrade the insulation of the chip capacitors. To a degradation, it is recommended following.			•		
		It is recommended to u Strong flux is not recom		ed rosin flux (less than 0.1wt% chlorine).		
		_		ovide proper amount of flux.		
		3) When water-soluble flux	k is used, enough w	ashing is necessary.		
		5-2. Recommended solderi	• .			
				ature, soldering temperature and these which is stipulated on the specification.		
		2) Chips should be mounted	•			
		 Enough preheating is no differences is less heat 		hip cracking. Small temperature		
		4) Temperature differences				
		Reflo	ow soldering			
		Preheating	Soldering Natural co	poling ,		
		•	→ 			
		Manual soldering (Solder iron) * Temperature of metal				
		300 Ω ΔT Ω Preh	neating 3sec. (As short	should not exceed 250°C.		
		5-3. Recommended soldering peak temp and peak temp duration				
		Temp./Duration	Reflow so	oldering		
		Solder Peak temp(°C) Duration(sec.) Sn-Pb Solder 230 max. 20 max.				
		Lead Free Solder	250 max.	10 max.		
		Recommended solder of Sn-37Pb (Sn-Pb solder Sn-3.0Ag-0.5Cu (Lead	er)			



No.	Process		Condi	tion	
5	Soldering	5-4. Avoiding thermal shock			
		Preheating condition		_	
		Soldering	Temp. (°C)	_	
		Reflow soldering	ΔT ≤ 130	_	
		Manual soldering	ΔT ≤ 130	_	
		cleaning, the temperature 5-5. Amount of solder Excessive solder w	re difference (ΔT)	must be less that	dipped into a solvent for n 100°C. n chip capacitors when in sufficient solder may
		detach the capacitors			in Sumclem Soluer may
		Excessive solder			her tensile force in capacitors to cause ck
		Adequate			m amount m abount
		Insufficient solder		cau chip	robustness may se contact failure or capacitors come off P.C.board.
		5-6. Solder repair by solder 1) Selection of the solderin Tip temperature of sold land size. The higher th However, heat shock in Please make sure the in accordance with follo capacitors with the con	ng iron tip der iron varies by in the tip temperature nay cause a crack tip temp. before s bowing recommend	e, the quicker the c in the chip capace oldering and keep ded condition. (Ple	operation. citors. o the peak temp and time ease preheat the chip
		Recommended solder	iron condition (Sr	n-Pb Solder and L	ead Free Solder)
		Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)
		300 max.	3 max.	20 max.	Ø 3.0 max.
		Direct contact of the sol cause crack. Do not tou iron.	•		, ,

No.	Process	Condition
5	Soldering	 5-7. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-8. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335B Annex 1 (Informative) Recommendations to prevent the tombstone phenomenon)
6	Cleaning	 If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance. If cleaning condition is not suitable, it may damage the chip capacitors. Insufficient washing Terminal electrodes may corrode by Halogen in the flux. Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance. Water soluble flux has higher tendency to have above mentioned problems (1) and (2). Excessive washing When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
7	Coating and molding of the P.C.board	 When the P.C.board is coated, please verify the quality influence on the product. Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors. Please verify the curing temperature.





No.	Process	Condition
10	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.
12	Others L Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (cars, electric trains, ships, etc.) (3) Medical equipment (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.



11. Packaging label

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Inspection No.
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

*Composition of Inspection No.

Example
$$\underline{M}$$
 $\underline{2}$ \underline{A} - \underline{OO} - \underline{OOO} (a) (b) (c) (d) (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

12. TAPE PACKAGING SPECIFICATION

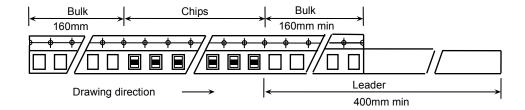
1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3(CKG32K).

Dimensions of plastic tape shall be according to Appendix 4(CKG45K, CKG45N, CKG57K, CKG57K).

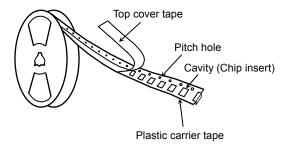
1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 5. Dimensions of Ø330 reel shall be according to Appendix 6.

1-4. Structure of taping

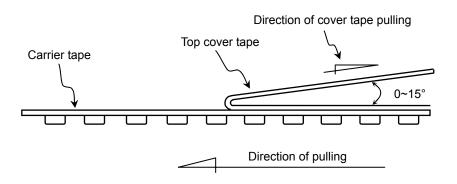


2. CHIP QUANTITY

Typo	Taping	Taping Chip quantity(pcs		
Туре	Material	φ178mm reel	φ330mm reel	
CKG32K		1,000	4,000	
CKG45K	plastic		1,000	
CKG57K			1,000	
CKG45N			1,000	
CKG57N			1,000	

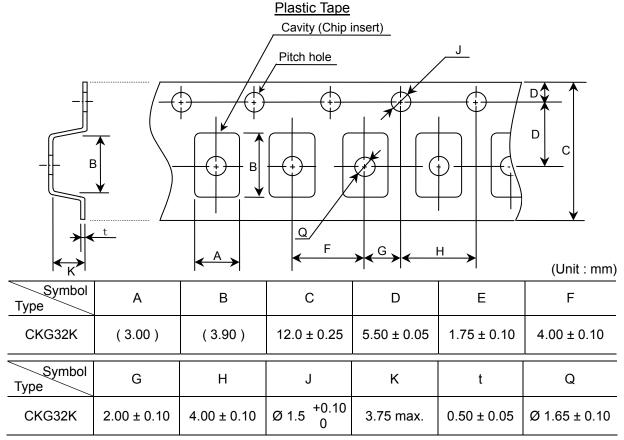
3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape) 0.05-0.7N. (See the following figure.)



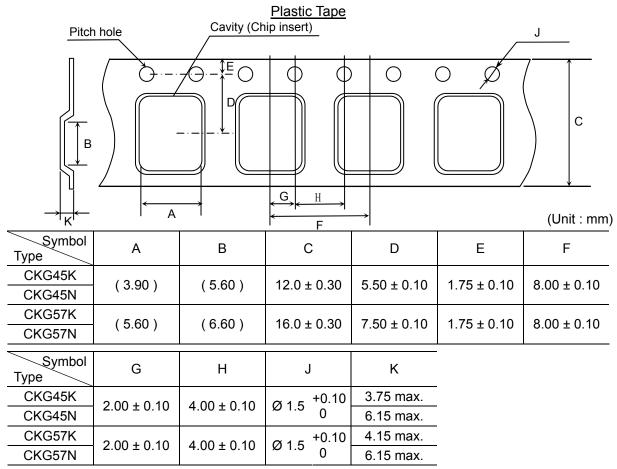
- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.

Appendix 3



^{*} The values in the parentheses () are for reference.

Appendix 4

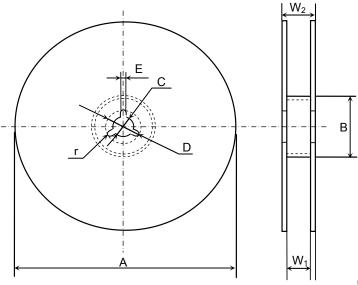


^{*} The values in the parentheses () are for reference.



Appendix 5

(Material : Polystyrene)



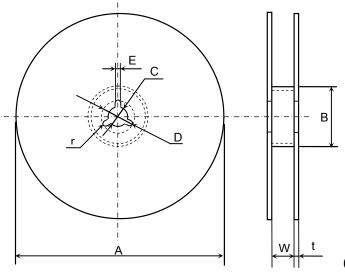
(Unit: mm)

Symbol Dimension	А	В	С	D	E	W ₁
CKG32	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.0 ± 0.3

Symbol Dimension	W ₂	r
CKG32	17.0 ± 1.4	1.0

Appendix 6

(Material : Polystyrene)



		Α	1	\rightarrow	<u>νν</u> (Uι	nit : mm)
Symbol Dimension	Α	В	С	D	Е	W
CKG32K	Ø382 max.					14.0 ± 1.5
CKG45K, CKG45N	(Nominal	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.5 ± 1.5
CKG57K, CKG57N	Ø330)					17.5 ± 1.5

Symbol Dimension	t	r	
CKG32			
CKG45K, CKG45N	2.0 ± 0.5	1.0	
CKG57K, CKG57N			